

Measurement Report for Device, TILT, WLAN 5GHz, Channel 100 (5500.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, Head Simulating Liquid	TILT, 0.00	WLAN 5GHz		5500.000, 100	4.87	5.11	35.4

Hardware Setup

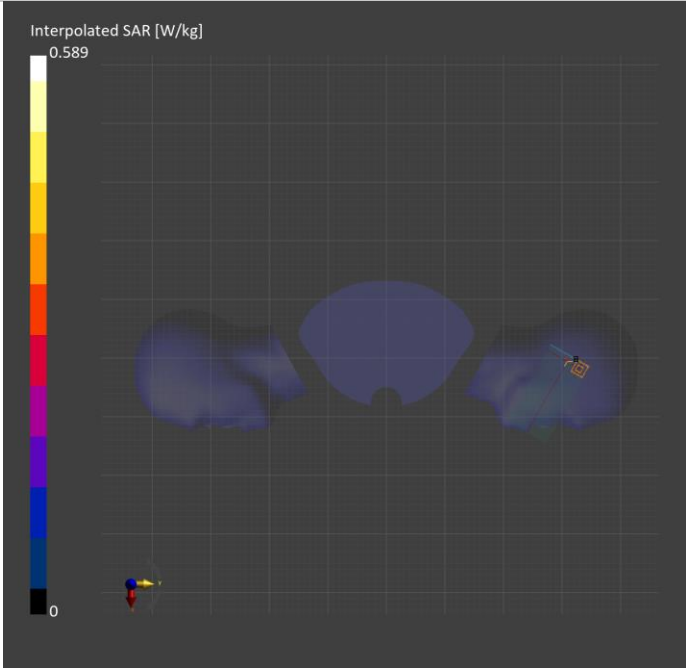
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1899	HBBL-600-10000 Charge:xxxx, --	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.2
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-05-11	2025-05-11
psSAR1g [W/kg]	0.070	0.082
psSAR10g [W/kg]	0.017	0.014
Power Drift [dB]	1.50	-0.17
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		67.7
Dist 3dB Peak [mm]		3.8



Measurement Report for Device, BACK, WLAN 5GHz, Channel 100 (5500.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 10.00	WLAN 5GHz		5500.000, 100	4.87	5.11	35.4

Hardware Setup

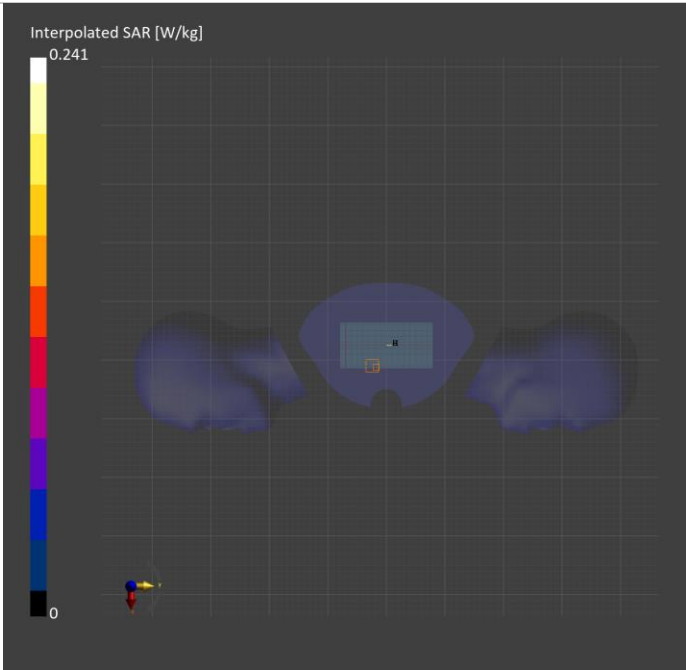
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1899	HBBL-600-10000 Charge:xxxx, --	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-05-11	2025-05-11
psSAR1g [W/kg]	0.028	0.039
psSAR10g [W/kg]	0.008	0.006
Power Drift [dB]	N/A	-1.17
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		72.4
Dist 3dB Peak [mm]		4.8



Measurement Report for Device, TILT, WLAN 5GHz, Channel 159 (5795.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, Head Simulating Liquid	TILT, 0.00	WLAN 5GHz		5795.000, 159	4.84	5.17	35.4

Hardware Setup

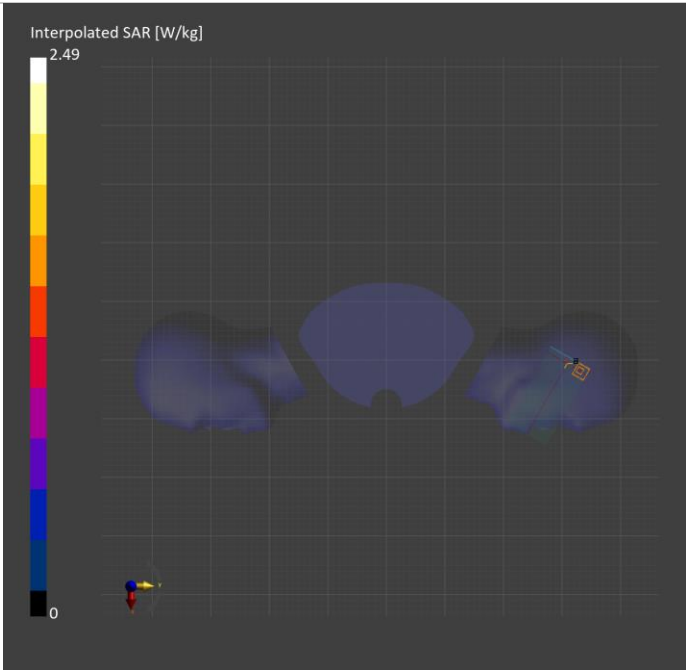
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1899	HBBL-600-10000 Charge:xxxx, --	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.2
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-05-15	2025-05-15
psSAR1g [W/kg]	0.085	0.097
psSAR10g [W/kg]	0.022	0.017
Power Drift [dB]	1.36	0.06
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		64.8
Dist 3dB Peak [mm]		4.0



Measurement Report for Device, BACK, WLAN 5GHz, Channel 159 (5795.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	0		Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 10.00	WLAN 5GHz		5795.000, 159	4.84	5.17	35.4

Hardware Setup

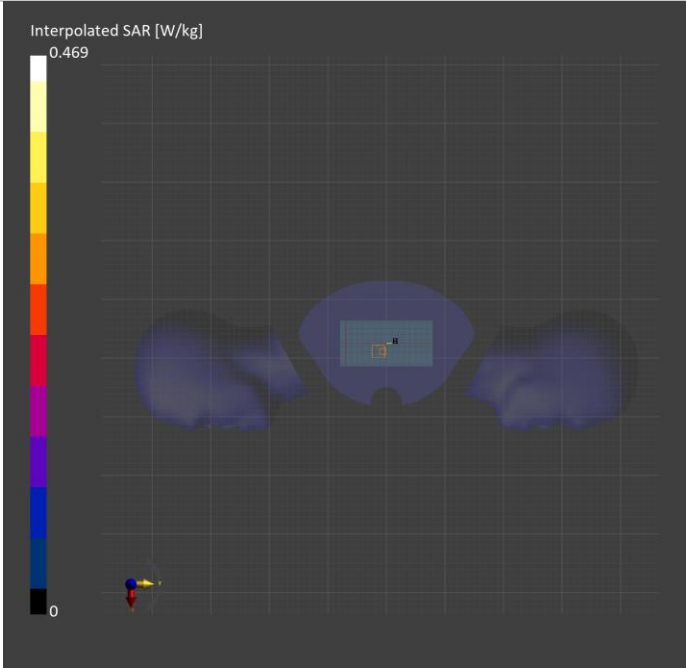
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1899	HBBL-600-10000 Charge:xxxx, --	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.2
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-05-15	2025-05-15
psSAR1g [W/kg]	0.071	0.074
psSAR10g [W/kg]	0.023	0.016
Power Drift [dB]	-1.57	-0.43
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		65.9
Dist 3dB Peak [mm]		4.7



Measurement Report for Device, CHEEK, Band n5, Channel 165300 (826.500MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HBBL 5-10000MHz	CHEEK, 0.00	Band n5		826.500, 165300	10.45	0.912	41.5

Hardware Setup

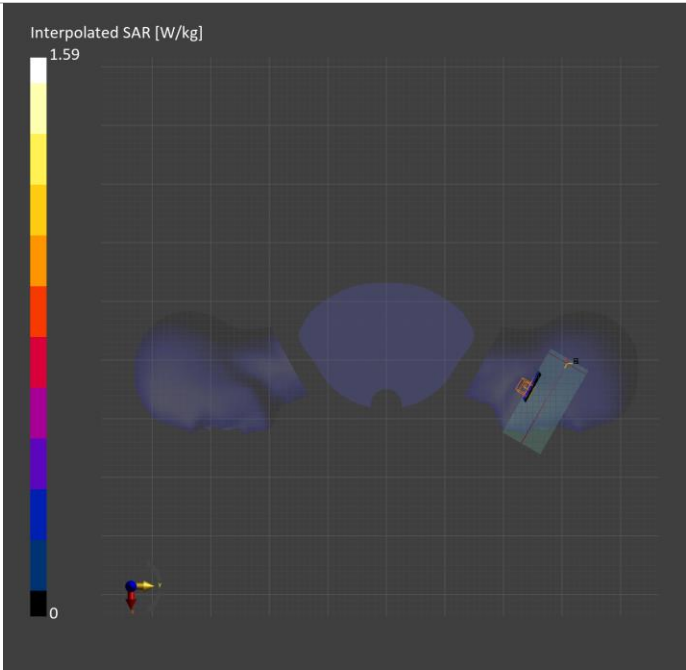
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-03-26	2025-03-26
psSAR1g [W/kg]	0.637	0.743
psSAR10g [W/kg]	0.397	0.399
Power Drift [dB]	-0.12	-0.16
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		72.5
Dist 3dB Peak [mm]		6.3



Measurement Report for Device, BACK, Band n5, Channel 165300 (826.500MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HBBL 5-10000MHz	BACK, 10.00	Band n5		826.500, 165300	10.45	0.912	41.5

Hardware Setup

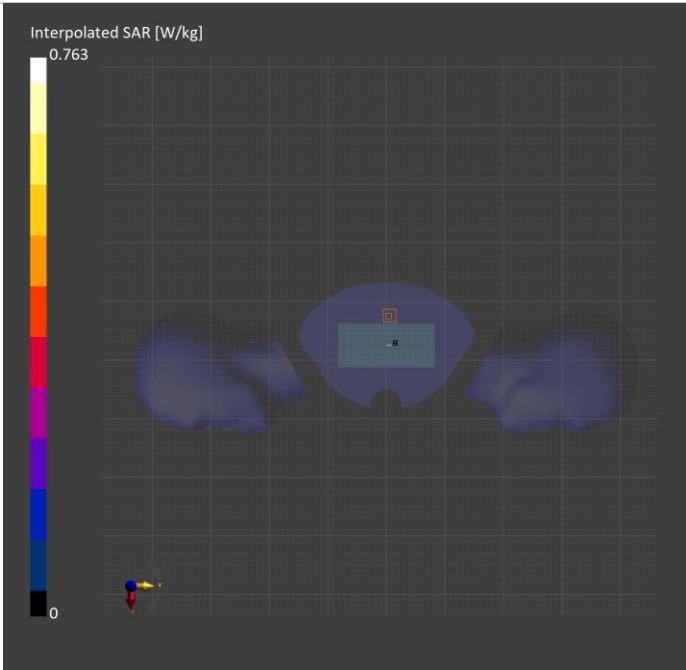
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-03-26	2025-03-26
psSAR1g [W/kg]	0.409	0.421
psSAR10g [W/kg]	0.259	0.251
Power Drift [dB]	0.00	-0.13
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		80.0
Dist 3dB Peak [mm]		10.8



Measurement Report for Device, TILT, Band n7, Channel 512500 (2562.500MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HBBL 5-10000MHz	TILT, 0.00	Band n7		2562.500, 512500	7.9	1.90	39.1

Hardware Setup

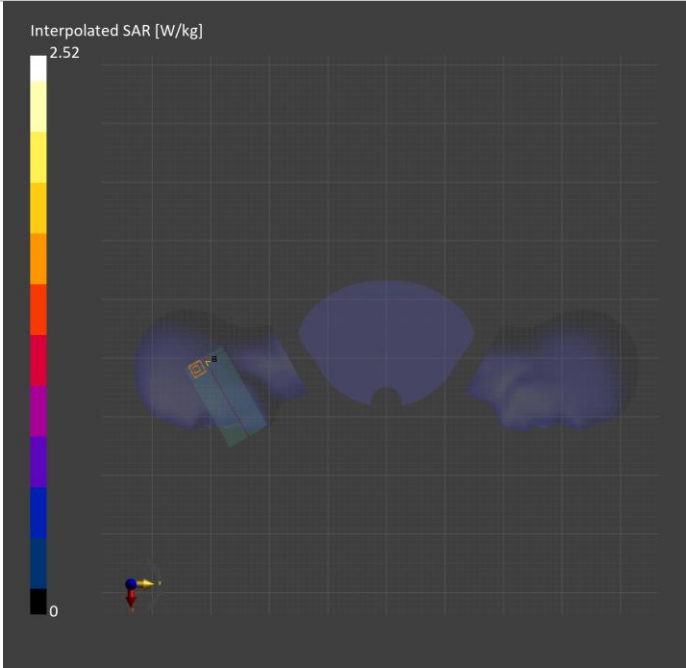
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-09	2025-04-09
psSAR1g [W/kg]	0.899	0.928
psSAR10g [W/kg]	0.360	0.346
Power Drift [dB]	-0.12	-0.19
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		74.1
Dist 3dB Peak [mm]		6.1



Measurement Report for Device, BACK, Band n7 , Channel 512500 (2562.500MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HBBL 5-10000MHz	BACK, 10.00	Band n7		2562.500, 512500	7.9	1.90	39.1

Hardware Setup

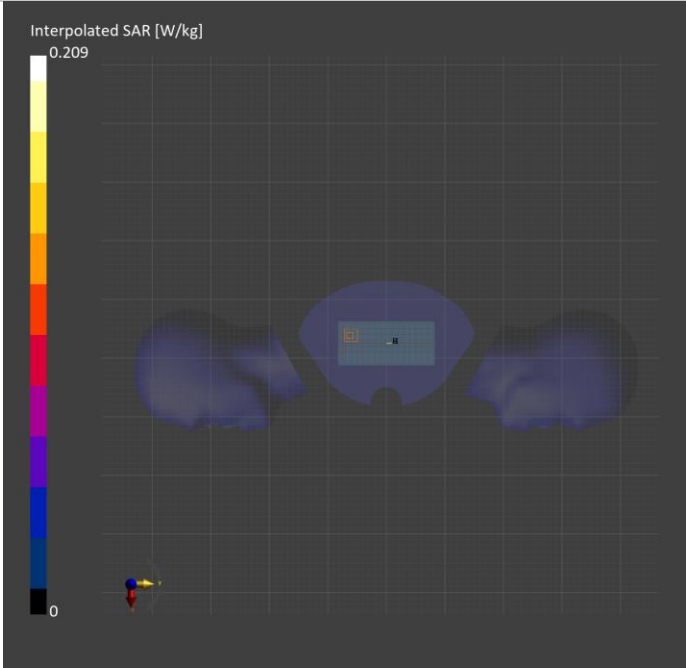
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	All points	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-09	2025-04-09
psSAR1g [W/kg]	0.098	0.102
psSAR10g [W/kg]	0.051	0.051
Power Drift [dB]	-0.04	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		78.7
Dist 3dB Peak [mm]		11.5



Measurement Report for Device, CHEEK, Band n12, Channel 142200 (711.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HBBL 5-10000MHz	CHEEK, 0.00	Band n12		711.000, 142200	10.45	0.891	42.2

Hardware Setup

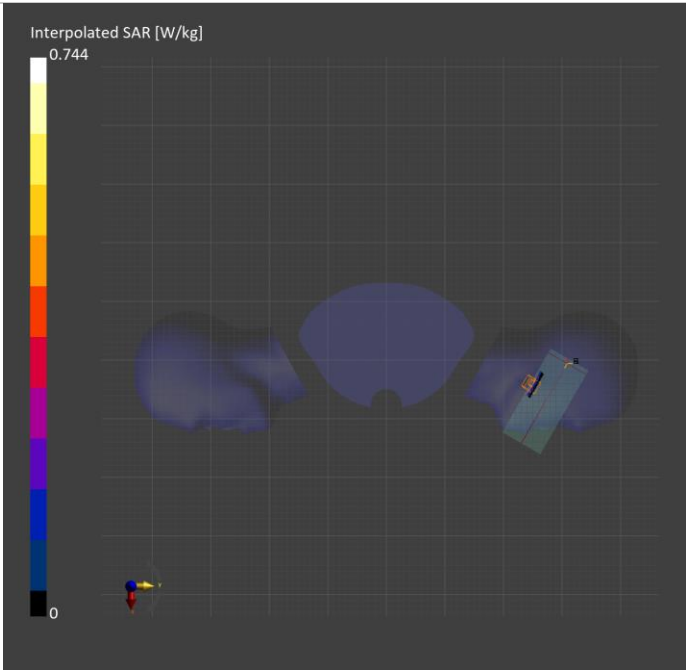
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-03-21	2025-03-21
psSAR1g [W/kg]	0.297	0.305
psSAR10g [W/kg]	0.178	0.154
Power Drift [dB]	-0.04	-0.21
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		75.0
Dist 3dB Peak [mm]		3.7



Measurement Report for Device, BACK, Band n12, Channel 142200 (711.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HBBL 5-10000MHz	BACK, 10.00	Band n12		711.000, 142200	10.45	0.891	42.2

Hardware Setup

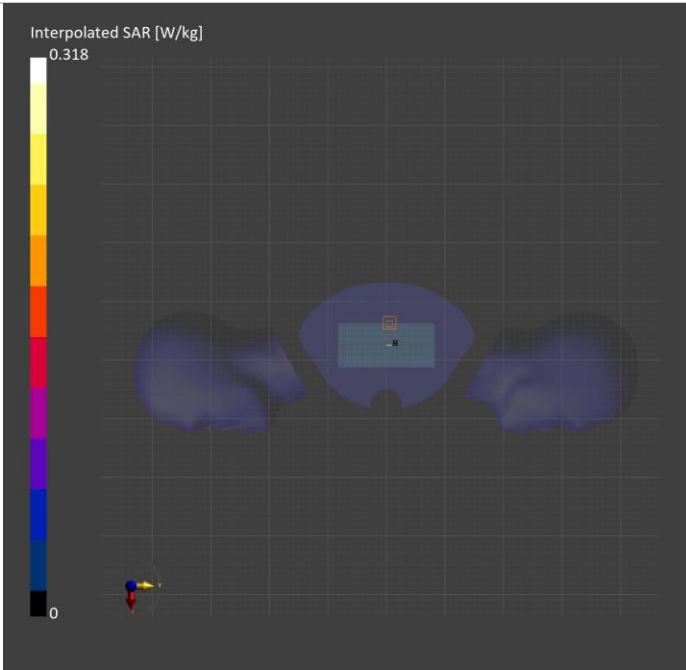
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-03-21	2025-03-21
psSAR1g [W/kg]	0.158	0.182
psSAR10g [W/kg]	0.105	0.111
Power Drift [dB]	-0.04	-0.13
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		83.0
Dist 3dB Peak [mm]		10.8



Measurement Report for Device, TILT, Band n38, UID 10900 AAC, Channel 515500 (2577.500MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	165.0 x 75.0 x 8.0		Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HBBL 5-10000MHz	TILT, 0.00	Band n38		2577.500, 515500	7.7	1.96	39.0

Hardware Setup

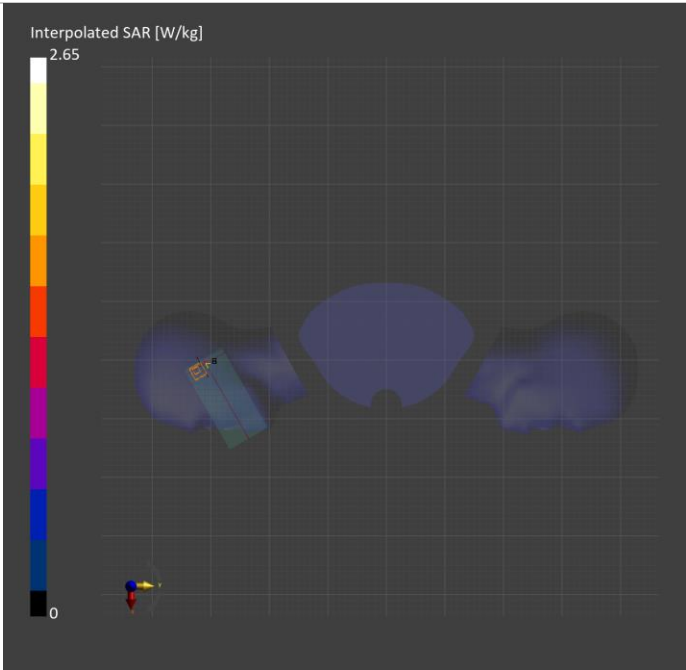
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-12	2025-04-12
psSAR1g [W/kg]	0.786	0.752
psSAR10g [W/kg]	0.318	0.312
Power Drift [dB]	-0.22	0.31
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		72.5
Dist 3dB Peak [mm]		4.1



Measurement Report for Device, BACK, Band n38, Channel 515500 (2577.500MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HBBL 5-10000MHz	BACK, 10.00	Band n38		2577.500, 515500	7.7	1.96	39.0

Hardware Setup

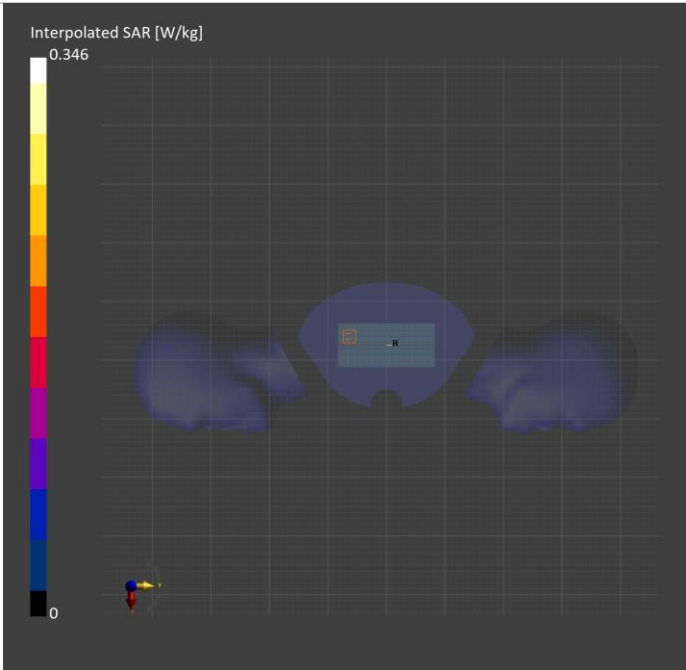
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-12	2025-04-12
psSAR1g [W/kg]	0.161	0.165
psSAR10g [W/kg]	0.083	0.079
Power Drift [dB]	-0.02	-0.11
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		78.7
Dist 3dB Peak [mm]		10.1



Measurement Report for Device, TILT, Band n41, Channel 504204 (2521.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HBBL 5-10000MHz	TILT, 0.00	Band n41		2521.000, 504204	7.7	1.96	39.0

Hardware Setup

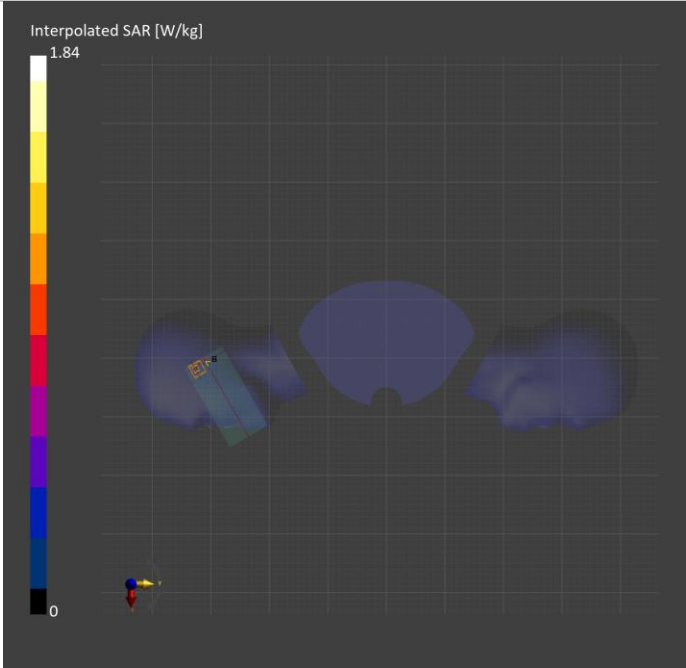
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-09	2025-04-09
psSAR1g [W/kg]	0.606	0.622
psSAR10g [W/kg]	0.243	0.228
Power Drift [dB]	-0.12	-0.13
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		70.5
Dist 3dB Peak [mm]		5.6



Measurement Report for Device, BACK, Band n41, Channel 504204 (2521.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HBBL 5-10000MHz	BACK, 10.00	Band n41		2521.000, 504204	7.7	1.96	39.0

Hardware Setup

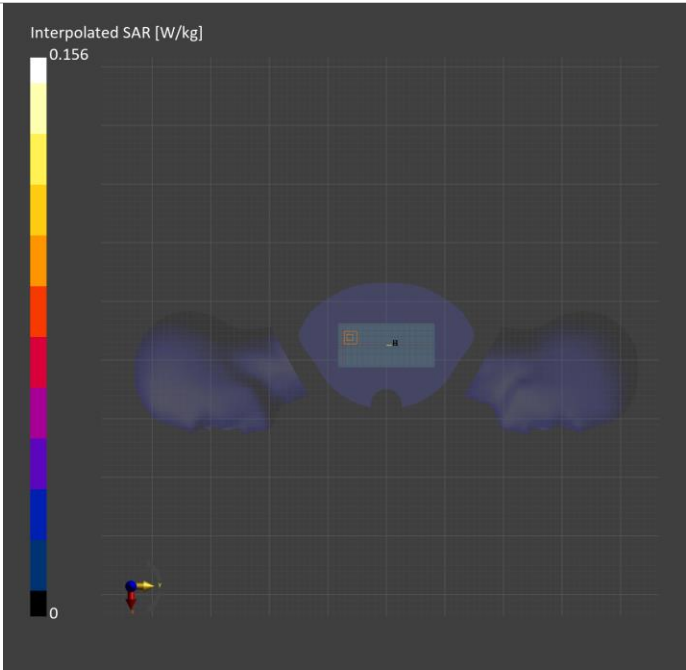
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	All points	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-09	2025-04-09
psSAR1g [W/kg]	0.069	0.074
psSAR10g [W/kg]	0.036	0.036
Power Drift [dB]	-0.11	0.08
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		77.4
Dist 3dB Peak [mm]		10.2



Measurement Report for Device, TILT, Band n66, Channel 349000 (1745.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HBBL 5-10000MHz	TILT, 0.00	Band n66		1745.000, 349000	8.72	1.37	40.1

Hardware Setup

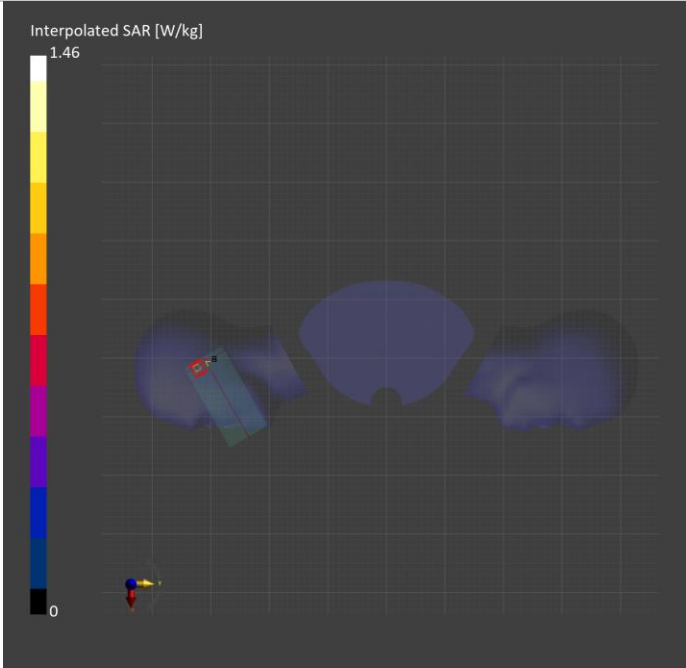
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-03-28	2025-03-28
psSAR1g [W/kg]	0.465	0.521
psSAR10g [W/kg]	0.241	0.224
Power Drift [dB]	-0.12	-0.18
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		67.7
Dist 3dB Peak [mm]		6.2



Measurement Report for Device, BACK, Band n66, Channel 349000 (1745.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HBBL 5-10000MHz	BACK, 10.00	Band n66		1745.000, 349000	8.72	1.37	40.1

Hardware Setup

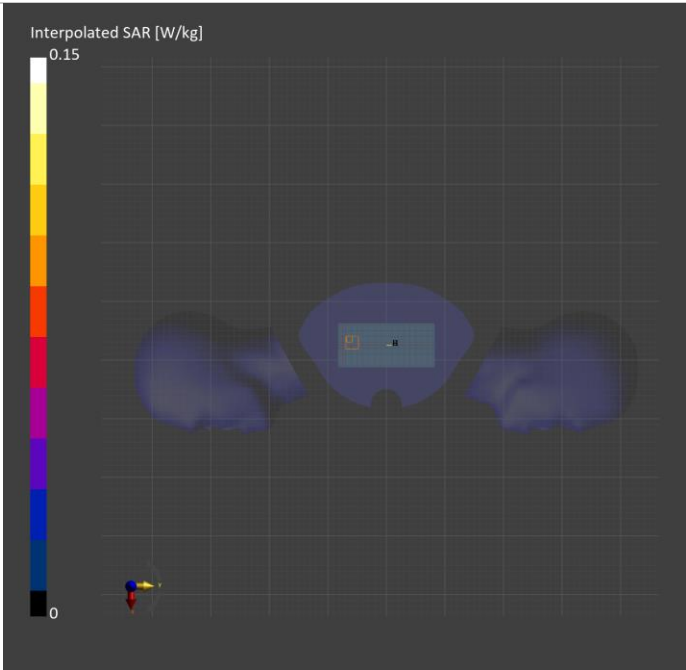
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	All points	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-03-28	2025-03-28
psSAR1g [W/kg]	0.077	0.082
psSAR10g [W/kg]	0.046	0.048
Power Drift [dB]	-0.06	-0.11
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		81.8
Dist 3dB Peak [mm]		11.4



Measurement Report for Device, CHEEK, Band n71, Channel 133100 (665.500MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HBBL 5-10000MHz	CHEEK, 0.00	Band n71		665.500, 133100	10.45	0.889	42.3

Hardware Setup

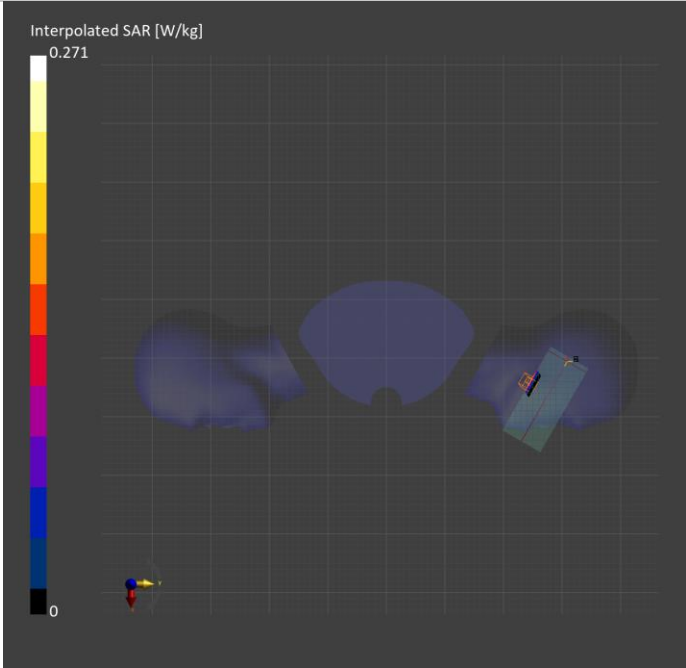
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-03-21	2025-03-21
psSAR1g [W/kg]	0.108	0.121
psSAR10g [W/kg]	0.066	0.064
Power Drift [dB]	-0.18	-0.04
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		72.5
Dist 3dB Peak [mm]		4.9



Measurement Report for Device, BACK, Band n71, Channel 133100 (665.500MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HBBL 5-10000MHz	BACK, 10.00	Band n71		665.500, 133100	10.45	0.889	42.3

Hardware Setup

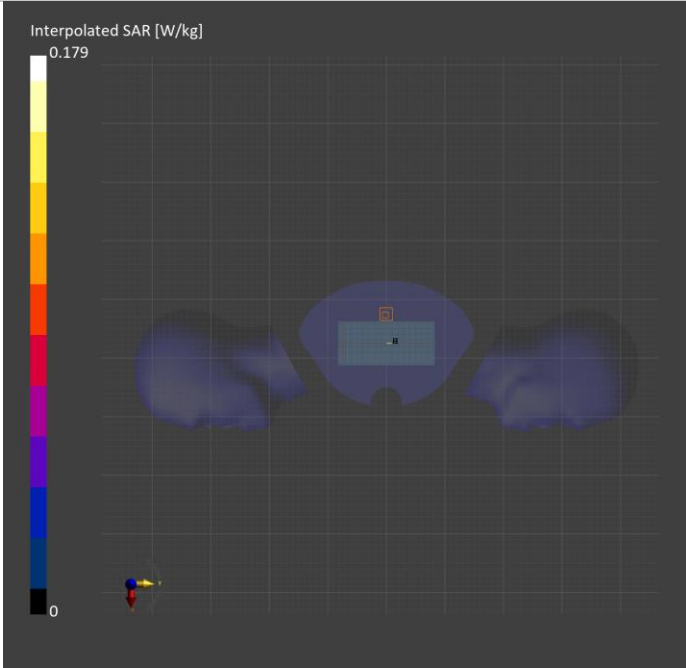
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-03-21	2025-03-21
psSAR1g [W/kg]	0.099	0.101
psSAR10g [W/kg]	0.063	0.061
Power Drift [dB]	-0.04	-0.05
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		80.7
Dist 3dB Peak [mm]		10.8



Measurement Report for Device, TILT, Band n77, Channel 631668 (3475.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HBBL 5-10000MHz	TILT, 0.00	Band n77		3475.000, 631668	7.0	2.92	37.9

Hardware Setup

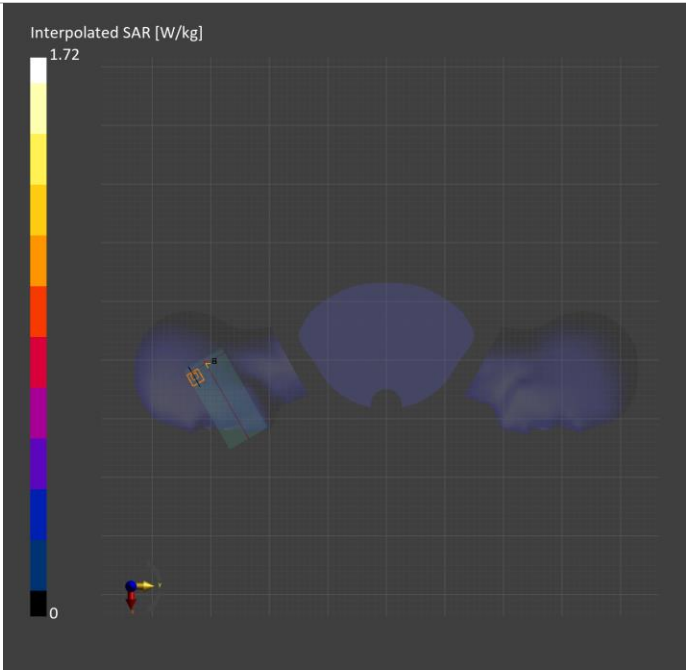
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-22	2025-04-22
psSAR1g [W/kg]	0.425	0.528
psSAR10g [W/kg]	0.184	0.192
Power Drift [dB]	-0.05	-0.13
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		67.6
Dist 3dB Peak [mm]		5.8



Measurement Report for Device, BACK, Band n77, Channel 631668 (3475.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HBBL 5-10000MHz	BACK, 10.00	Band n77		3475.000, 631668	7.0	2.92	37.9

Hardware Setup

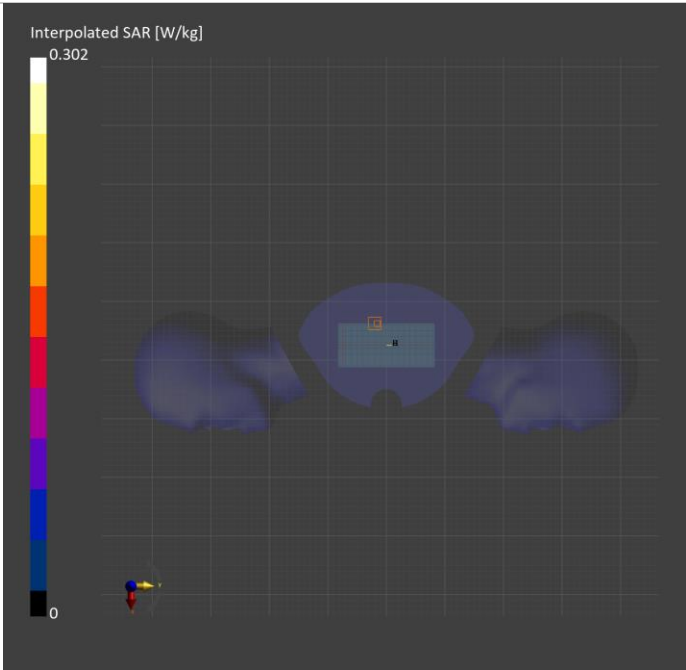
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-22	2025-04-22
psSAR1g [W/kg]	0.123	0.125
psSAR10g [W/kg]	0.058	0.057
Power Drift [dB]	-0.13	0.07
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		75.6
Dist 3dB Peak [mm]		10.8



Measurement Report for Device, TILT, Band n77, Channel 638334 (3575.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HBBL 5-10000MHz	TILT, 0.00	Band n77		3575.000, 638334	6.8	3.04	37.8

Hardware Setup

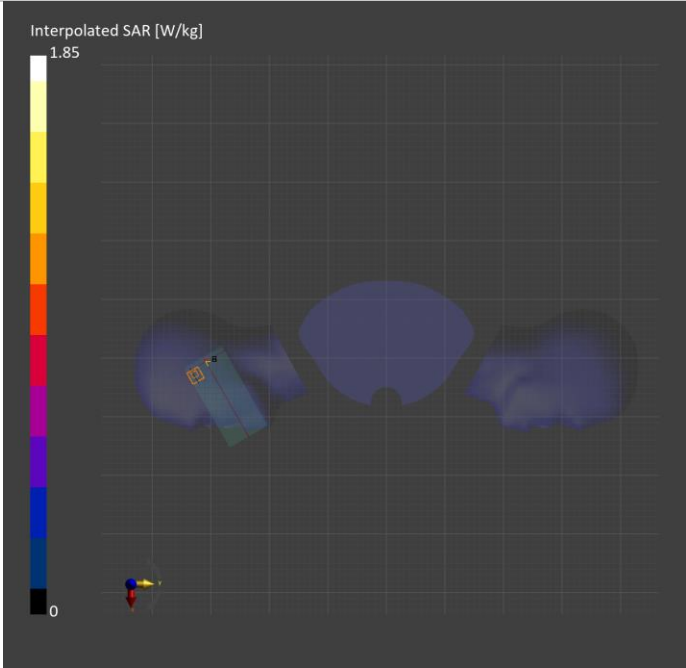
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-22	2025-04-22
psSAR1g [W/kg]	0.453	0.572
psSAR10g [W/kg]	0.191	0.201
Power Drift [dB]	-0.15	-0.15
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		70.4
Dist 3dB Peak [mm]		6.0



Measurement Report for Device, BACK, Band n77, Channel 638334 (3575..000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HBBL 5-10000MHz	BACK, 10.00	Band n77	5G NR FR1 TDD, 10900-AAC	3575.000, 638334	6.8	3.04	37.8

Hardware Setup

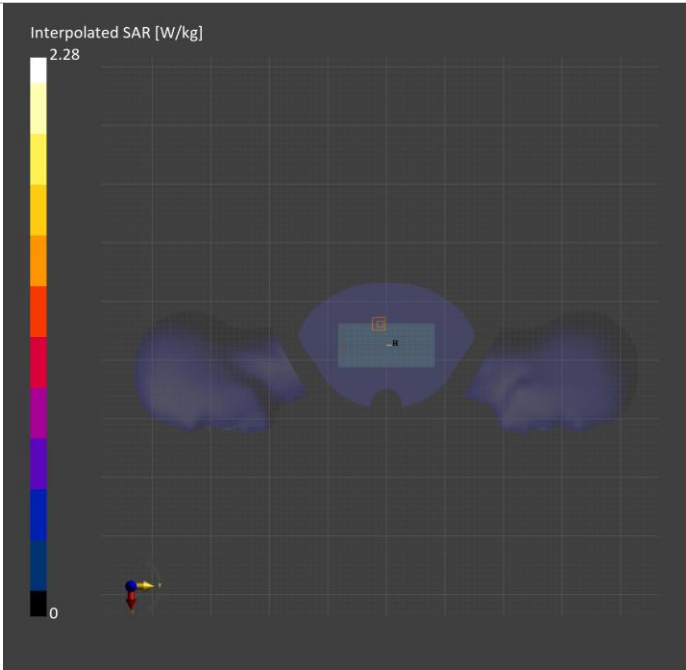
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-22	2025-04-22
psSAR1g [W/kg]	0.137	0.144
psSAR10g [W/kg]	0.062	0.062
Power Drift [dB]	-0.07	-0.18
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		75.7
Dist 3dB Peak [mm]		10.5



Measurement Report for Device, TILT, Band n77 , Channel 662000 (3930.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HBBL 5-10000MHz	TILT, 0.00	Band n77		3930.000, 662000	6.7	3.27	37.5

Hardware Setup

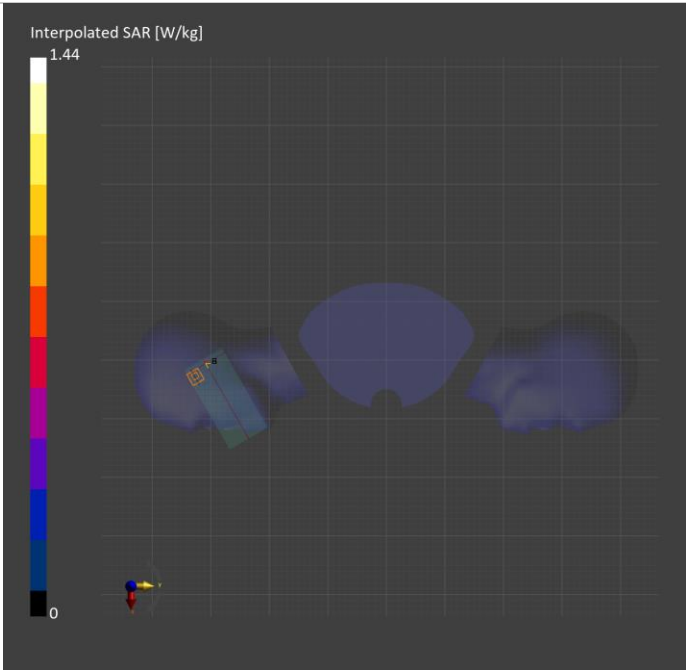
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-05-01	2025-05-01
psSAR1g [W/kg]	0.374	0.451
psSAR10g [W/kg]	0.146	0.153
Power Drift [dB]	-0.14	-0.14
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		70.2
Dist 3dB Peak [mm]		5.9



Measurement Report for Device, BACK, Band n77, Channel 662000 (3930.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HBBL 5-10000MHz	BACK, 10.00	Band n77		3930.000, 662000	6.7	3.27	37.5

Hardware Setup

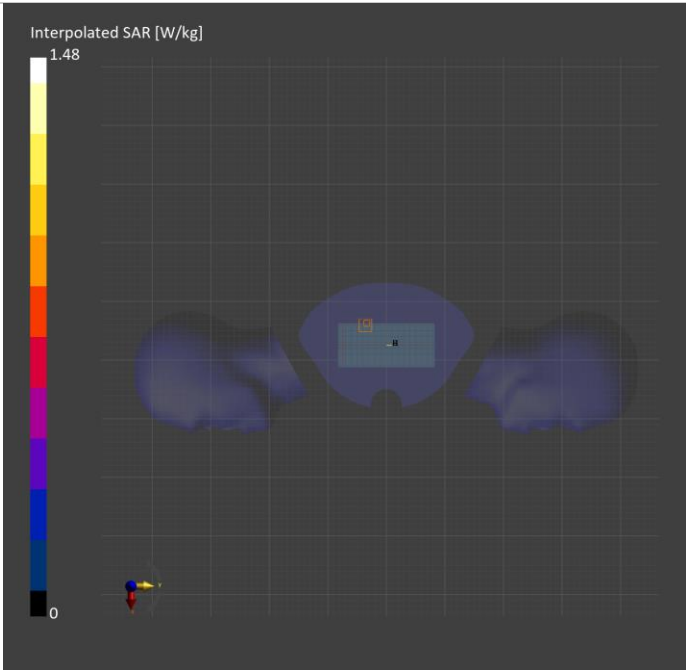
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-05-01	2025-05-01
psSAR1g [W/kg]	0.094	0.097
psSAR10g [W/kg]	0.041	0.041
Power Drift [dB]	-0.12	-0.09
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		72.7
Dist 3dB Peak [mm]		10.3



Measurement Report for Device, TILT, Band n78, Channel 630334 (3455.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HBBL 5-10000MHz	TILT, 0.00	Band n78		3455.000, 630334	7.0	2.92	37.9

Hardware Setup

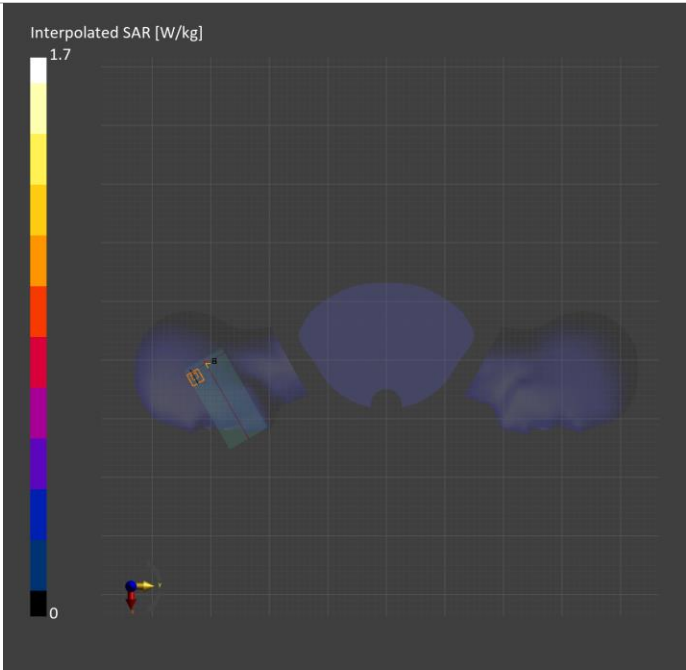
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-05-01	2025-05-01
psSAR1g [W/kg]	0.445	0.534
psSAR10g [W/kg]	0.193	0.196
Power Drift [dB]	-0.06	-0.09
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		68.7
Dist 3dB Peak [mm]		6.3



Measurement Report for Device, BACK, Band n78, Channel 630334 (3455.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HBBL 5-10000MHz	BACK, 10.00	Band n78	5G NR FR1 TDD, 10900-AAC	3455.000, 630334	7.0	2.92	37.9

Hardware Setup

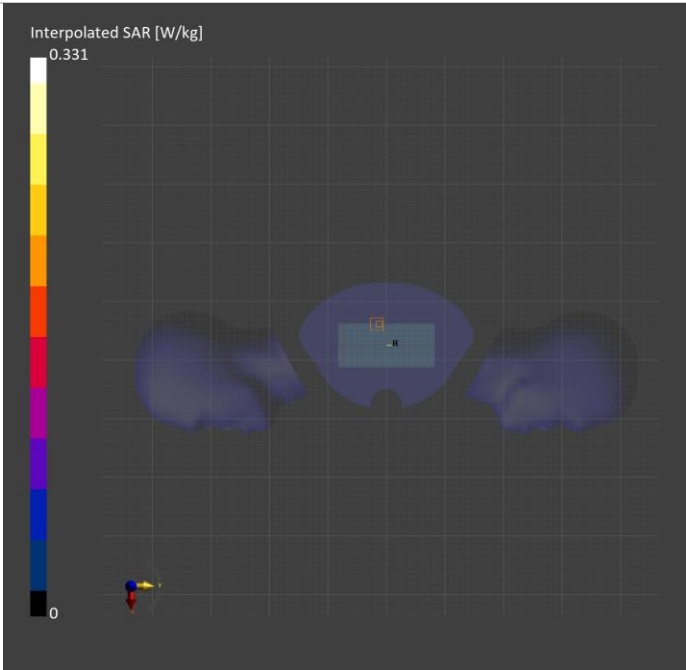
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-05-01	2025-05-01
psSAR1g [W/kg]	0.131	0.138
psSAR10g [W/kg]	0.062	0.062
Power Drift [dB]	-0.10	0.07
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		75.8
Dist 3dB Peak [mm]		10.1



Measurement Report for Device, TILT, Band n78, Channel 641666 (3624.990MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HBBL 5-10000MHz	TILT, 0.00	Band n78		3624.990, 641666	6.8	3.04	37.8

Hardware Setup

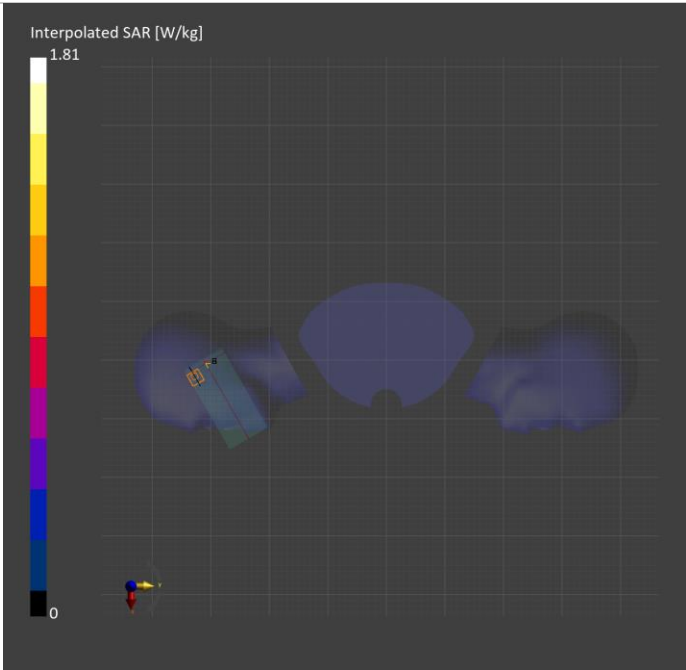
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-26	2025-04-26
psSAR1g [W/kg]	0.456	0.568
psSAR10g [W/kg]	0.193	0.201
Power Drift [dB]	-0.07	-0.09
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		68.4
Dist 3dB Peak [mm]		6.0



Measurement Report for Device, BACK, Band n78, UID 10900 AAC, Channel 641666 (3624.990MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HBBL 5-10000MHz	BACK, 10.00	Band n78		3624.990, 641666	6.8	3.04	37.8

Hardware Setup

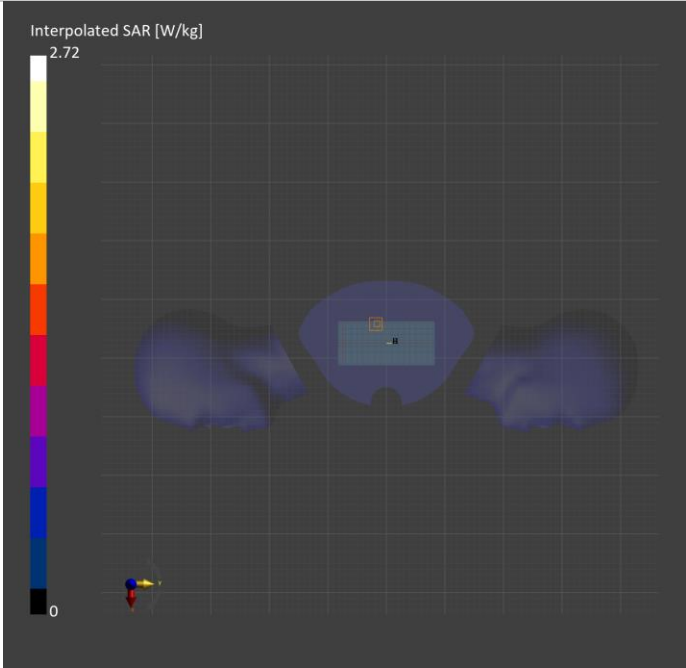
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-26	2025-04-26
psSAR1g [W/kg]	0.134	0.141
psSAR10g [W/kg]	0.061	0.060
Power Drift [dB]	-0.06	-0.10
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		75.7
Dist 3dB Peak [mm]		9.5



Measurement Report for Device, TILT, Band n78, , Channel 647000 (3705.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HBBL 5-10000MHz	TILT, 0.00	Band n78		3705.000, 647000	6.8	3.17	37.6

Hardware Setup

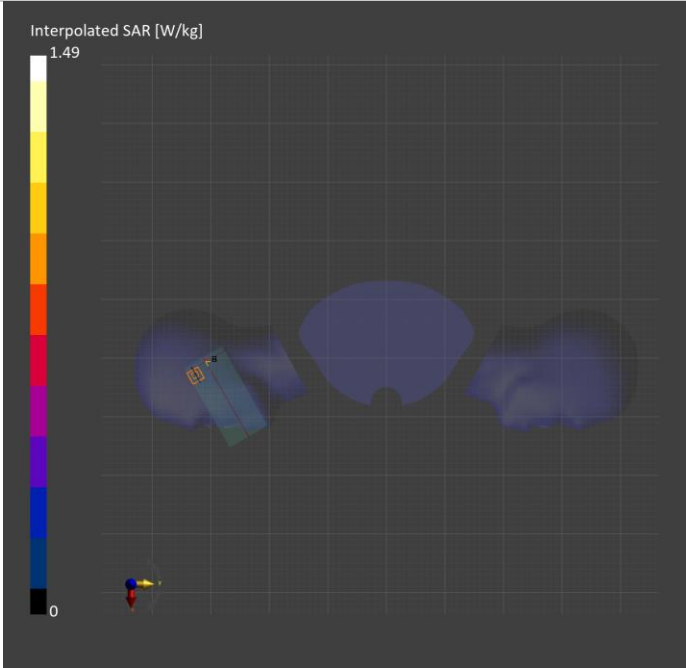
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-26	2025-04-26
psSAR1g [W/kg]	0.375	0.454
psSAR10g [W/kg]	0.150	0.154
Power Drift [dB]	-0.04	-0.12
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		68.3
Dist 3dB Peak [mm]		5.5



Measurement Report for Device, BACK, Band n78, Channel 647000 (3705.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,			Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HBBL 5-10000MHz	BACK, 10.00	Band n78		3705.000, 675000	6.8	3.17	37.6

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) - 1901	HBBL 5-10000MHz , --	EX3DV4 - SN7391, 2024-11-29	DAE4 Sn1495, 2024-07-24

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 200.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-04-26	2025-04-26
psSAR1g [W/kg]	0.093	0.080
psSAR10g [W/kg]	0.039	0.028
Power Drift [dB]	-0.48	-1.99
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		65.4
Dist 3dB Peak [mm]		5.1

